Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/810,351	KATSURA, TAKEHISA	
Examiner	Art Unit	
Lee Lum	3611	

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Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR